

**Search Notes**

Application/Control No.

10/501,917

Examiner

Binh X. Tran

Applicant(s)/Patent under  
Reexamination

KATSUNUMA, TAKAYUKI

Art Unit

1765

**SEARCHED**

| Class | Subclass | Date      | Examiner |
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| 438   | 711      | 4/21/2006 | BT       |
| 438   | 713      | 4/21/2006 | BT       |
| 438   | 728      | 4/21/2006 | BT       |
| 438   | 743      | 4/21/2006 | BT       |
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**INTERFERENCE SEARCHED**

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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

|  | DATE      | EXMR |
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| Search keywords and inventor's name<br>using USPAT, USPGPUB, JPO, EPO,<br>DERWENT database | 4/21/2006 | BT   |
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